TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSII⁻⁵)

2SK1120

DC-DC Converter and Motor Drive Applications

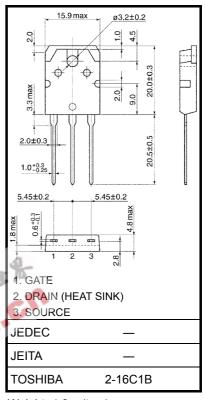
Unit: mm

 $\begin{array}{ll} \bullet & \text{Low drain-source ON resistance} & : \text{RDS (ON)} = 1.5 \ \Omega \ \text{(typ.)} \\ \bullet & \text{High forward transfer admittance} & : |Y_{fs}| = 4.0 \ S \ \text{(typ.)} \\ \bullet & \text{Low leakage current} & : I_{DSS} = 300 \ \mu\text{A (max) (V}_{DS} = 800 \ \text{V}) \\ \end{array}$

• Enhancement mode : $V_{th} = 1.5 \sim 3.5 \text{ V (Vps} = 10 \text{ V, Ip} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	1000	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	1000	V	
Gate-source voltage		V_{GSS}	±20	V	
Drain current	DC (Note 1)	ID	8	AO	
	Pulse (Note 1)	I _{DP}	24		
Drain power dissipation (Tc = 25°C)		PD	150	W	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 4.6 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	0.833	°C / W
Thermal resistance, channel to ambient	R _{th (ch-a)}	50	°C / W

Note 1: Ensure that the channel temperature does not exceed 150°C.

This transistor is an electrostatic-sensitive device.

Please handle with caution.

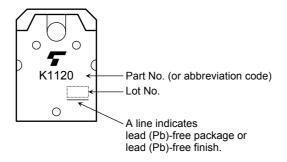
Electrical Characteristics (Ta = 25°C)

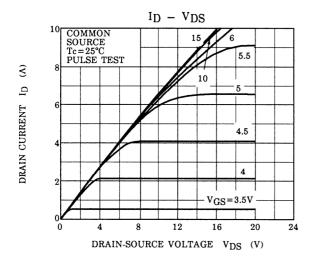
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	irrent	I _{GSS}	V _{GS} = ±20 V, V _{DS} = 0 V	_	_	±100	nA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 800 V, V _{GS} = 0 V	-	_	300	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	1000	_	_	V
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 4 A	_	1.5	1.8	Ω
Forward transfer	r admittance	Y _{fs}	V _{DS} = 20 V, I _D = 4 A	2.0	4.0	_	S
Input capacitano	e	C _{iss}		_	1300	_	
Reverse transfe	r capacitance	C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	100	_	pF
Output capacita	t capacitance C _{oss}		_	180	_		
Switching time -	Rise time	t _r	V _{GS} _{0V} V _{OUT} _{R_L} =100Ω	_	25	_	- ns
	Turn-on time	t _{on}		_	40	_	
	Fall time	t _f		_	20	_	
	Turn-off time	t _{off}	$V_{DD} = 400V$ Duty $\leq 1\%$, $t_w = 10 \mu s$	_	100	_	
Total gate charg plus gate-drain)		Qg	次节·		120	_	
Gate-source charge		Q _{gs}	$V_{DD} \approx 400 \text{ V, } V_{GS} = 10 \text{ V, } I_D = 8 \text{ A}$	_	70	_	nC
Gate-drain ("miller") charge		Q _{gd}		_	50	_	

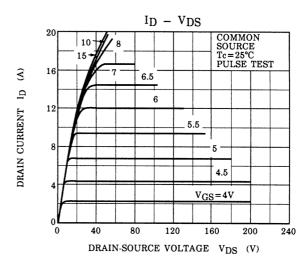
Source-Drain Ratings and Characteristics (Ta = 25°C)

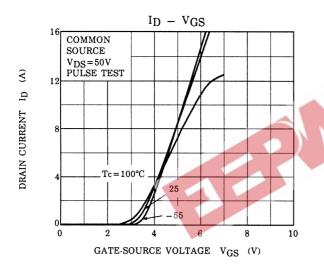
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	l _{DR}	_		_	8	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_		_	24	Α
Forward voltage (diode)	V_{DSF}	I _{DR} = 8 A, V _{GS} = 0 V		_	-1.9	V

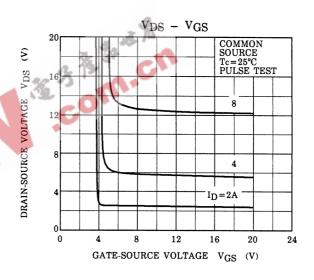
Marking

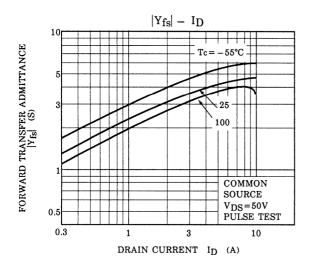


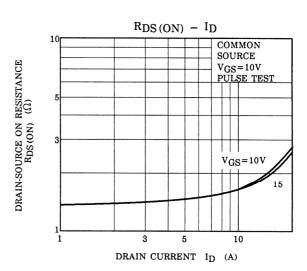




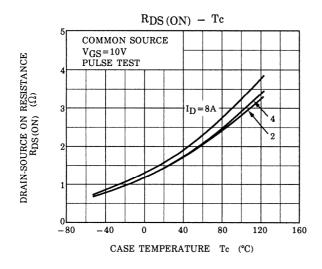


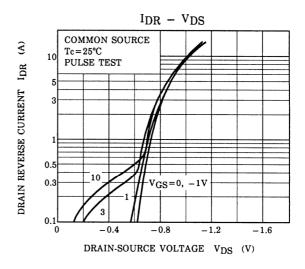


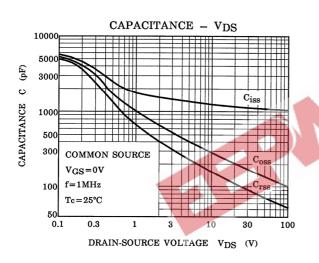


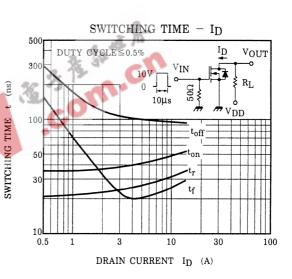


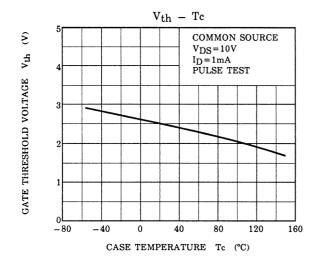
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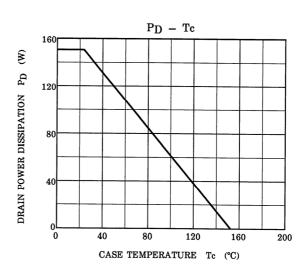


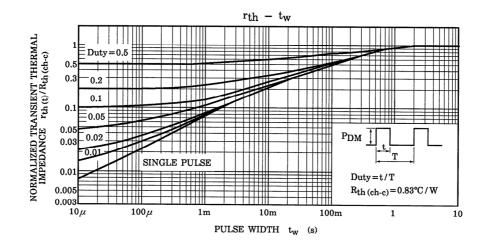


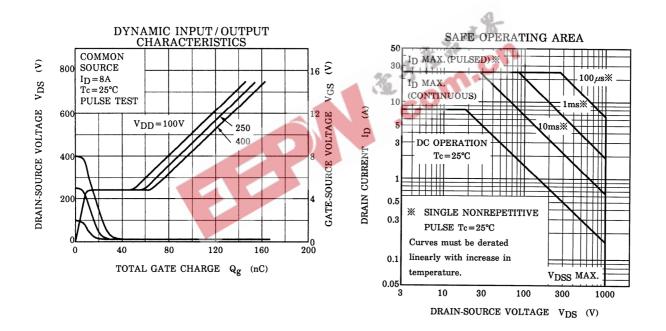












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